Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/089,409	AIKOH ET AL.		
Examiner	Art Unit		
TAN X. DINH	2653		

	SEAR	SEARCHED		
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (see search history printout)	3/13/2006	T.D		
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